

Supplementary Material

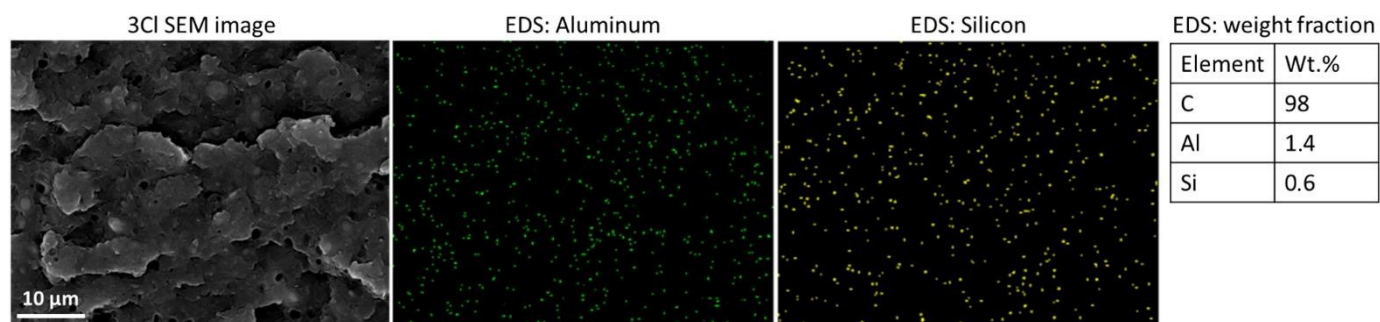


Figure S1. Al and Si EDS mapping on the SEM image of 3CI and weight fraction of the detected elements.

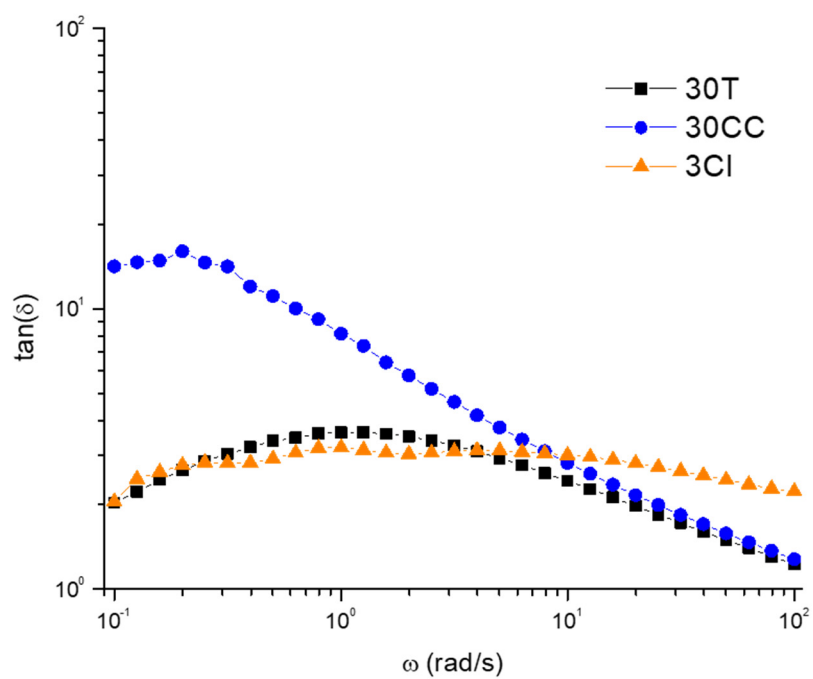


Figure S2. $\tan\delta$ as a function of frequency for PP-based materials. The curves were recorded at 200 °C.